# Technical Construction File

Tcf No:	CE-WZ25070801-SO-EMC
Applicant:	Wenzhou Zhongzhe Electric Co., Ltd
Address:	No. 29, Huancheng East Road, Liushi Town, Yueqing City, Wenzhou City, Zhejiang Province
Manufacturer:	Wenzhou Zhongzhe Electric Co., Ltd
Address:	No. 29, Huancheng East Road, Liushi Town, Yueqing City, Wenzhou City, Zhejiang Province
Product:	Terminal blocks
Model:	KE-2155, KE-2166, KE-2166P, BEN-2166P, WSL-1000AVS, AVS20, VP-2166, VP-2166D, 0R-SD-P20, OR-SD-P12, LW-2166D, N-MT2626A1, UN1VEX-2155, TVPS-16C, N-MT2624B1, KE-V16P, DB2000, DVP-1426, FDD-KE-2155-120v, AVS-20, KE-2188, PS-21689P, HJ-2166B, FE-2166P, BC-DVP2201, JL-VPPB2000, DP-D7PV, TV~FRIDGE GUARD, TV~FRIDGE PROTECTOR, TV GUARD, FRIDGE GUARD
Test standard:	EN IEC 61000-6-4:2019 EN IEC 61000-6-2:2019
Conclusion:	The products meet the above standards.
Edit Date:	2025-07-08
Issue date:	2025-07-08

#### ASSESSMENT REPORT

TCF

Tested by(+ signature).....: Project Engineer, Melody

Reviewed by(+ signature)...... Manager, Tracy

Date of issue .....: 2025-07-08

Client

Name .....: Wenzhou Zhongzhe Electric Co., Ltd

City, Zhejiang Province

Test specification

Standard .....: EN IEC 61000-6-2:2019, EN IEC 61000-6-4:2019

Test procedure .....: CE-EMC

Non-standard test method .....: N.A.

Test item description:

Manufacturer....: Wenzhou Zhongzhe Electric Co., Ltd

Factory....: Wenzhou Zhongzhe Electric Co., Ltd

Trademark .....: Refer to the nameplate

Model, Type reference ...... Refer to page 1

Rating(s) ....: refer to the nameplate.

**General product information:** The product is Terminal blocks.

Test Result: PASS.

The product meets the all the test requirements. The details are listed in the following documents.

### **Test Conditions**

### **Environmental Conditions**

The climatic conditions during the tests are within the limits specified by the manufacturer for the operation of the EUT and the test equipment.

The climatic conditions during the tests were within the following limits:

Temperature Humidity		Atmospheric pressure	
15 °C – 35 °C	30 % - 60 %	860 hPa – 1060 hPa	

If explicitly required in the basic standard or applied product standard the climatic values are recorded and documented separately in this test report.

### Performance Criteria

	Clause 5					
Criteria	During test After test					
	The apparatus shall continue to opera	ate as intended during the test. No				
	degradation of performance or loss of	function is allowed below a				
	performance level specified by the ma	anufacturer, when the apparatus is				
A	used as intended. If the minimum per	formance level or the permissible				
	performance loss is not specified by t	he manufacturer, then either of these				
	may be derived from the product desc	cription and documentation, and from				
	what the user may reasonable expect	from the apparatus if used as				
	intended.					
В	The apparatus shall continue to operate as in performance or loss of function is allowed be manufacturer, when the apparatus is used as performance is allowed, however no change allowed to persist after test. If the minimum p performance loss is not specified by the man from the product description and documentate expect from the apparatus if used as intende	low a performance level specified by the intended. During the test, degradation of of actual operating state or stored data is erformance level or the permissible ufacturer, then either of these may be derived ion, and from what the user may reasonable				
	Temporary loss of function is allowed	, provided the function is				
С	self-recoverable or can be restored by	y the operation of the controls, or by				
	any operation specified in the instruct	ion for use.				

# **Test Conditions Environmental Conditions**

The climatic conditions during the tests are within the limits specified by the manufacturer for the operation of the EUT and the test equipment.

The climatic conditions during the tests were within the following limits:

Temperature	Humidity	Atmospheric pressure
15 °C – 35 °C	30 % - 60 %	860 hPa – 1060 hPa

If explicitly required in the basic standard or applied product standard the climatic values are recorded and documented separately in this test report.

### **Performance Criteria**

Criteria	During test	After test
А	The apparatus shall continue to operate degradation of performance or loss of performance level specified by the managed as intended. If the minimum perperformance loss is not specified by the may be derived from the product described what the user may reasonable expectintended.	f function is allowed below a anufacturer, when the apparatus is formance level or the permissible he manufacturer, then either of these cription and documentation, and from
В	The apparatus shall continue to operate degradation of performance or loss of performance level specified by the maused as intended. During the test, deghowever no change of actual operating persist after test. If the minimum performance loss is not specified by the may be derived from the product described what the user may reasonable expectintended.	f function is allowed below a anufacturer, when the apparatus is gradation of performance is allowed, ng state or stored data is allowed to ormance level or the permissible he manufacturer, then either of these cription and documentation, and from
С	Temporary loss of function is allowed self-recoverable or can be restored by any operation specified in the instruct	y the operation of the controls, or by

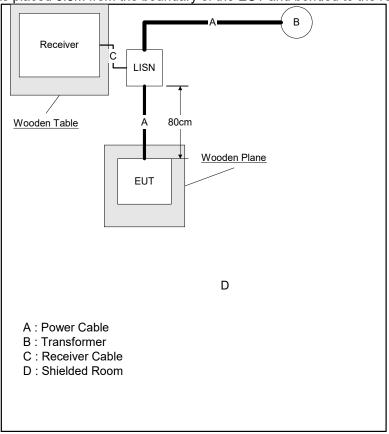
**Test Details** 

#### **Conducted Disturbance**

### **Test Method**

The EUT was placed on a 0.8 m non-conductive table for table-top equipment and on a 0.12 m insulated support for floor standing equipment above a ground reference plane all within a test laboratory.

All power was connected to the EUT through an Artificial Mains Network (AMN). Conducted disturbance voltage measurements on mains lines were made at the output of the AMN. The AMN was placed 0.8m from the boundary of the EUT and bonded to the reference ground plane.



### **Specification Limits**

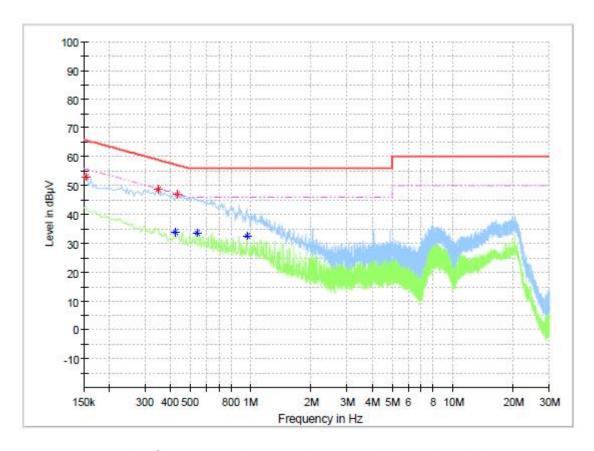
Disturbance voltage limits for class B equipment for AC power input port						
Frequency range	AC mains port dB(μV)					
MHz	Quasi-peak	Quasi-peak Average				
0.15 to 0.5	66	56				
	decreasing linearly with	decreasing linearly with				
	logarithm of frequency to	logarithm of frequency to				
	56 46					
0.5 to 5	56	46				
5 to 30	60	50				

### **Test Location**

This test was carried out in shielded room.

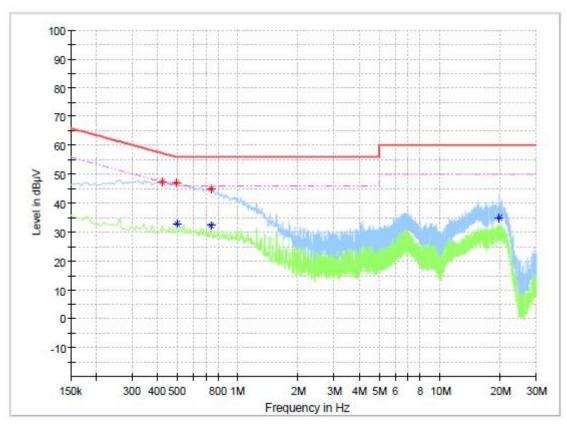
### **Test Results**

Remark : L1



No significant emission was detected within 6 dB to limit.

Remark : N



No significant emission was detected within 6 dB to limit.

#### **Radiated Disturbance**

#### **Test Method**

The EUT was set up in a semi-anechoic chamber on a remotely controlled turntable and placed on a non-conductive. Guidance on how to arrange the EUT during the measurements can be found in 5.3.4.3.

Table-top EUT shall be placed at  $(0.8 \pm 0.05)$  m above the reference plane of the test site

selected for measurement.

Floor standing EUT shall be placed at  $(0.12 \pm 0.04)$  m above the reference plane of the test

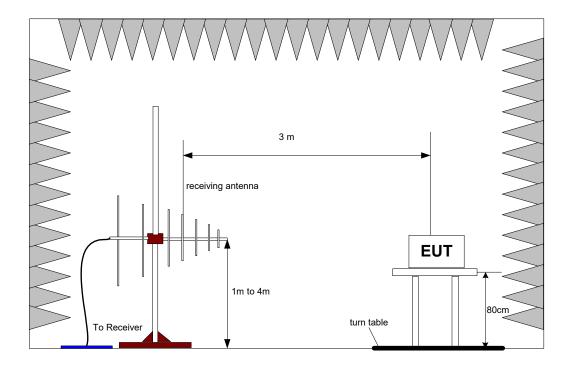
site selected for measurement.

Where the EUT comprises multiple parts, these shall be arranged to minimise, as far as it is

reasonably practical, the test volume. A minimum distance of 0,1 m shall be maintained

between these parts.

A prescan of the EUT emissions profile was made while varying the antenna-to-EUT azimuth and antenna-to-EUT polarization using a peak detector; measurements were taken at a 3m or 10m distance. Using the prescan list of the highest emissions detected, their bearing and associated antenna polarization, the EUT was then formally measured using a Quasi-Peak detector. The readings were maximized by adjusting the antenna height, polarization and turntable azimuth, in accordance with the specification.



### **Specification Limits**

Radiated disturbance limits in the frequency range 30MHz to			
1000MHz at a measuring distance of 3 m			
Frequency range MHz Quasi-peak limits dB(µV, m)			
30 to 230 40			
230 to 1000 47			

Radiated disturbance limits in the frequency range 30MHz to				
1000MHz at a measuring distance of 10 m				
Frequency range MHz Quasi-peak limits dB(µV, m)				
30 to 230 30				
230 to 1000	37			

Radiated disturbance limits in the frequency range 1000MHz to					
6000MHz	6000MHz at a measuring distance of 3 m				
Frequency range Quasi-peak limits Average					
MHz dB(μV, m)					
1000 to 3000 70 50					
3000 to 6000	74	54			

### Remark:

Level=Reading Level + Correction Factor

Correction Factor=Antenna Factor + Cable Loss

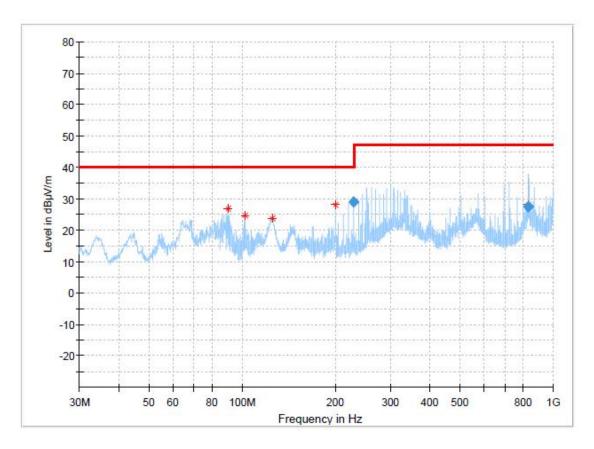
(The Reading Level is recorded by software which is not shown in the sheet)

### **Test Location**

This test was carried out in 3m SAC Test Location.

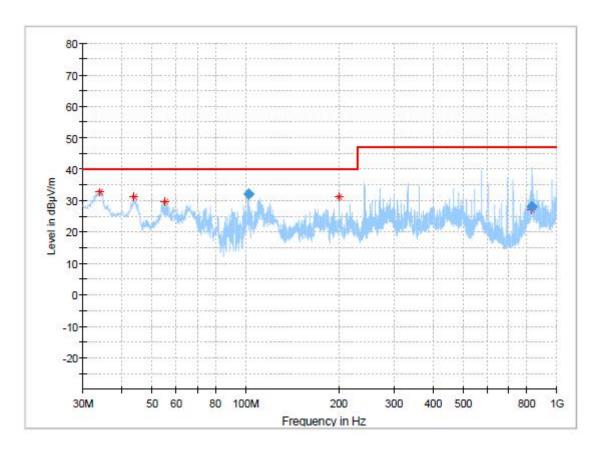
**Test Results** 

Polarity : Horizontal



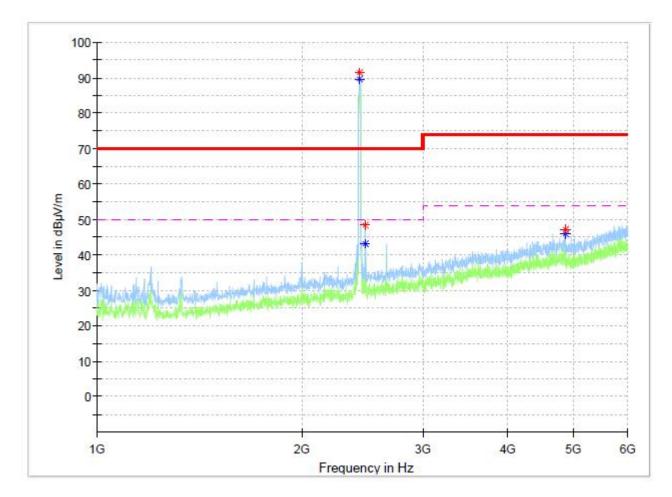
No significant emission was detected within 6 dB to limit.





No significant emission was detected within 6 dB to limit.

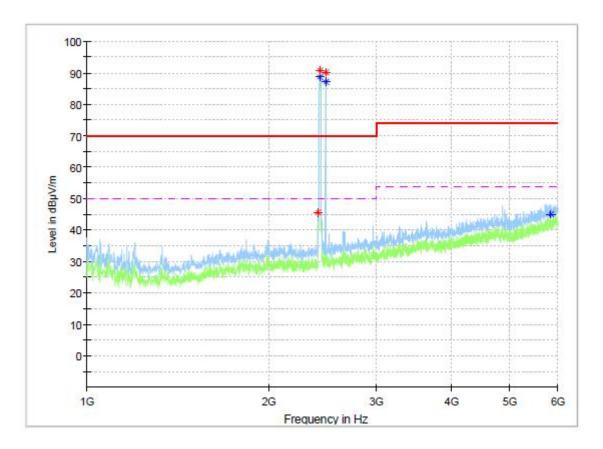




# No significant emission was detected within 6 dB to limit

Frequency (MHz)	MaxPeak (dBμV, m)	Average (dBµV, m)	Limit (dBµV, m)	Margin (dB)	Pol
2430.000000	1	89.48	50.00	-39.48	Н
2430.000000	91.44		70.00	-21.44	Н
2477.500000	48.46		70.00	21.54	Н
2477.500000		43.11	50.00	6.89	Н

Polarity : Vertical



No significant emission was detected within 6 dB to limit

Frequency (MHz)	MaxPeak (dBµV, m)	Average (dBµV, m)	Limit (dBµV, m)	Margin (dB)	Pol
2407.500000	45.64		70.00	24.36	V
2426.250000	90.65		70.00	-20.65	V
2426.250000		88.68	50.00	-38.68	V
2480.000000	90.24	-	70.00	-20.24	V
2480.000000		87.14	50.00	-37.14	V

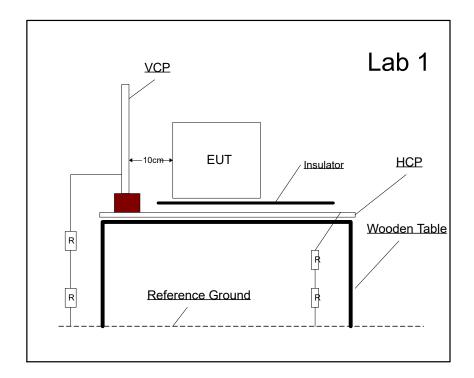
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### Electrostatic discharge immunity test Test Method

The equipment under test including associated cabling was configured on but insulated from, using a 0.5mm isolator, a horizontal coupling plane fitted to the top of a 0.8m non-conductive table for table-top equipment; and on a 0.1m insulated support for floor standing equipment; above a ground reference plane all within a test laboratory.

Using the air discharge method for non-metallic parts, contact discharge method for metallic parts with both vertical and horizontal couple plane discharge methods for the sides of the equipment under test, the required electrostatic discharge voltage levels in both voltage polarities were applied at the detailed pulse repartition rate.

During this testing any anomalies in the equipment under tests performance was recorded.



**Specification Limits** 

tion Limits				
	Discharge Level (kV)		Number of	   Performanc
Discharge type			discharges per	e Criteria
Discharge type	Positive Negative	location	e Ciliena	
			(each polarity)	
Air – Direct	8	8	10	В
Contact –	1	4	10	R
Direct	4	4	10	Ь
Contact –	4	4	10	В

Indirect		

### **Test Results**

Performance assessment of the EUT made during this test: Pass

Detailed results are shown below.

		Results: Met Performance Criteria									
Test Point	Discharge	21	κV	41	kV	6k	:V	81	κV	15	kV
		+	-	+	-	+	-	+	-	+	-
НСР	Contact	N, A	N, A	А	А	А	Α	N, A	N, A	N, A	N, A
VCP	Contact	N, A	N, A	А	А	А	Α	N, A	N, A	N, A	N, A
Each conductive location touchable by hand	Contact	N, A	N, A	А	А	А	Α	N, A	N, A	N, A	N, A
Each nonconductive location touchable by hand	Air	N, A	N, A	N, A	N, A	N, A	N, A	А	Α	N, A	N, A
N, A	Not Applian	се									

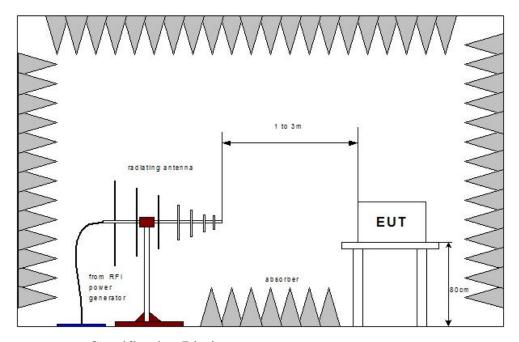
Remark: No observable change.

### Radiated, radio-frequency, electromagnetic field immunity test Test Method

The equipment under test including associated cabling was configured, on a 0.8 m non-conductive table for table-top equipment and on a 0.12 m insulated support for floor standing equipment; with a pre-calibrated semi anechoic chamber.

All four side of the equipment under test were subjected to the required RF field strength, modulated as described, swept over the frequency range of test with the antenna positioned in both horizontal and vertical polarizations.

During this testing any anomalies in the equipment under tests performance was recorded.



**Specification Limits** 

	Performance				
Frequency Range (MHz)					
80 to 6000	3	AM (80 %,1 kHz, sine wave)	1	1	А

Note 1. EUT powered at one of the Nominal input voltages and frequencies

### **Test Results**

Performance assessment of the EUT made during this test: Pass

Detailed results are shown below.

Tabu	Tabulated Results for RF Electromagnetic Field 80 - 2700 MHz								
Side of the equipment under test	Antenna polarizatio n	Test Level	Dwell Time	Measuring distance	Result s				
Front, Left, Right, Back sides	Horizontal	3 V, m 80 to 6000MHz	1 s	3 m	A				
Front, Left, Right, Back sides	Vertical	3 V, m 80 to 6000MHz	1 s	3 m	A				

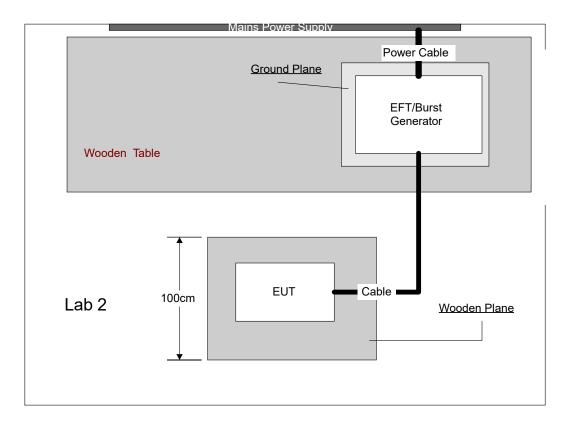
Remark: No observable change

# **Electrical fast transient , burst immunity test Test Method**

The equipment under test including associated cabling was configured on but insulated from, using a 0.1 m isolator, a horizontal coupling plane fitted to the top of a 0.8 m non-conductive table for table-top equipment; and on a 0.1 m insulated support for floor standing equipment; above a ground reference plane all within a test laboratory.

Using a CDN for power ports, capacitive coupling clamp for signal and control ports and a 33nF coupling capacitor for earth ports, the required fast transient burst voltage levels in both voltage polarities were applied at the detailed pulse repartition rate and duration of test.

During this testing any anomalies in the equipment under tests performance was recorded.



### **Specification Limits**

Required T	est Levels	Input and			
Line Under Test	Level (kV)	Repetition Rate (kHz)	Test Duration	Coupling Method	Performance Criteria
Input and output a.c. power ports	± 2.0	5 kHz	2 min per polarity	Direct	В

For extra low voltage a.c. ports and output a.c. ports, this testing is only applicable to ports interfacing with cables whose total length may exceed 3 m according to the manufacturer's functional specification.

Required						
		control lines	1			
Line Under Test	Under Level (kV) Repetition   Test   Coupling   Rate (kHz) Duration   Method					
Signal and control lines	± 1.0	5 kHz	2 min per polarity	Clamp	В	

Applicable only to ports interfacing with cables whose total length can exceed 3m according to the manufacturer's function specification.

#### **Test Results**

Performance assessment of the EUT made during this test: Pass

Detailed results are shown below.

Tabulated Results for Fast Transient Burst Immunity							
Line under test							
Input a.c. power ports	± 2.0 kV	5 kHz	2 min	Direct	А		

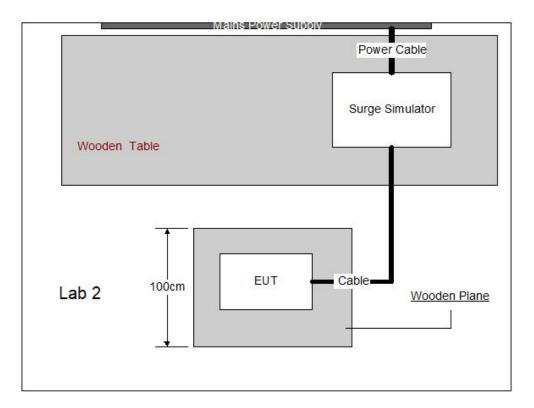
Remark: During the test of the network port, the signal interrupts. After the test, it can automatically return to normal status.

# **Surge immunity test Test Method**

The equipment under test including associated cabling was configured, on a 0.8 m non-conductive table for table-top equipment and on a 0.1 m insulated support for floor standing equipment above a ground reference plane all within a test laboratory.

Using CDNs for power ports and appropriate coupling methods for applicable signal and control ports, the required number of surges was applied for each surge voltage level using both positive and negative surge voltage polarities. Surges were applied at the power line frequency phase angles and repartition rates detailed.

During this testing any anomalies in the equipment under tests performance was recorded.



### **Specification Limits**

	Performance					
Line Under Test	Line Under Test   Characteristics   Test Levels					
	Wave-shape data	1.2, 50 µs				
line to line with	2Ω impedance	± 1.0 kV	В			
line to earth with	12Ω impedance	±2.0 kV				

Note in addition to the specified test level, all lower levels as detailed in IEC 61000-4-5 should also be satisfied.

For CPT ports: Applicable only to ports interfacing with cables whose total length according to the manufacturer's functional specification is greater than 30 m.

Ports fo	Performance						
Line Under Test	Line Under Test Characteristics Test Levels						
	R						
line to earth with	42Ω impedance	± 1.0 kV	Ь				

Applicable only to ports interfacing with long distance lines(>30m).

Where the normal functioning cannot be achieved because of the impact of the coupling, decoupling network (CDN) on the EUT, the test shall be done with the reduced

functionality. A rationale shall be given in the test report for doing so. After the test and the removal of the CDN, the normal function shall not be affected.

### **Test Location**

This test was carried out in EMS Test Location.

# **Test Results**

Performance assessment of the EUT made during this test: Pass

Detailed results are shown below.

	Tabulated Results for Surge Immunity (a.c.Power Ports)									
Line Name	Coupling	Level	Polarity	Phase Angle	No of Pulses	Repetition Rate	Result			
Power line	Live to Neutral	1.0, 2.0kV	NEGATIVE	0, 90, 180,270	5	60 sec	А			
Power line	Live to Neutral	1.0, 2.0kV	POSITIVE	0, 90, 180,270	5	60 sec	А			
Power line	Live to Earth	2.0, 4.0kV	NEGATIVE	0, 90, 180,270	5	60 sec	А			
Power line	Live to Earth	2.0, 4.0kV	POSITIVE	0, 90, 180,270	5	60 sec	А			
Power line	Neutral to Earth	2.0, 4.0kV	NEGATIVE	0, 90, 180,270	5	60 sec	А			
Power line	Neutral to Earth	2.0, 4.0kV	POSITIVE	0, 90, 180,270	5	60 sec	А			

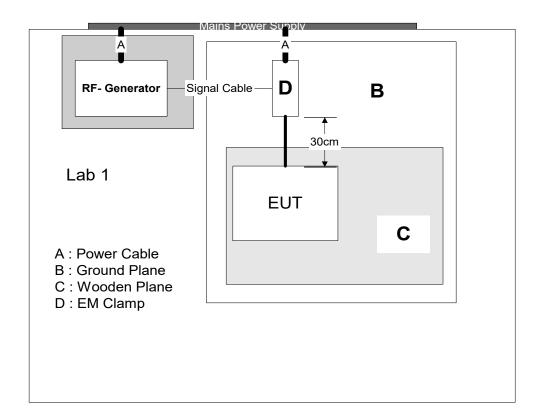
# Immunity to conducted disturbances, induced by radio-frequency fields Test Method

The equipment under test was configured, on but insulated from, using a 0.1 m isolator, a horizontal coupling plane fitted to the top of a 0.1 m non-conductive table for table-top equipment, above a ground reference plane all within a test laboratory.

All associated cabling was configured, on but insulated from, using a 50 mm isolator, the same horizontal coupling plane as the equipment under test.

Using CDNs, EM Clamps or current clamps as appropriate, the power ports and applicable signal and control ports were subjected to the required, pre calibrated RF injected signal strength, modulated as described, swept over the frequency range of test.

During this testing any anomalies in the equipment under tests performance was recorded.



### **Specification Limits**

	Required Test Levels						
	Input and	d output a	.c. power por	ts			
Line	Frequenc	Level		Step	Dwell		
Under	y Range		Modulation	Size		Performanc	
Test	(MHz)	(V)		(%)	(s)	e Criteria	
Input and							
output	0.15 to		AM (80 %,1				
a.c.	80	3	kHz, sine	1	1	Α	
power			wave)				
ports							

For extra low voltage a.c ports and output a.c. ports, this testing is only applicable to ports interfacing with cables whose total length may exceed 3 m according to the manufacturer's functional specification.

Р	orts for net	work and	signal, contro	l lines		
Line	Frequenc	Level		Step	Dwell	
Under	y Range	(V)	Modulation	Size	(s)	Performanc
Test	(MHz)	(V)		(%)	(5)	e Criteria
Signal			AM (80 %,1			
and	0.15 to	3	kHz, sine	1	1	Α
control	80	J	wave)	•	'	
port			vvavc)			

Applicable only to ports interfacing with cables whose total length may exceed 3m according to the manufacturer's function specification.

### **Test Results**

Performance assessment of the EUT made during this test: Pass

Detailed results are shown below.

Tabulated Results for Injected current, a.c. power ports						
Line and sensitive frequency under test	Test Level	Step	Dwell Time	Coupling Method	Modulation	Result
Power line	Power line 3V 1% 1s CDN 1kHz, 80% A					

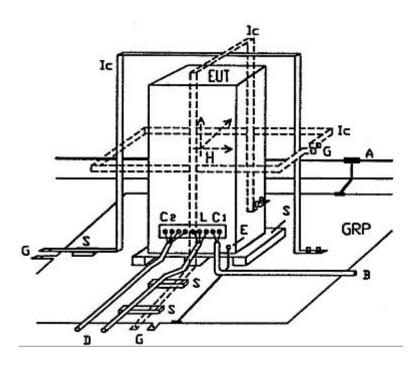
Remark: No observable change.

# Power-frequency magnetic field immunity test Test Method

The equipment under test including associated cabling was configured on a non-conductive support at the volumetric center of the immunity coils. A pre calibrated input level was then applied to magnetic immunity coils at the detailed frequency and level for the required test period.

The EUT was retested with the magnetic field applied in all 3 orthogonal planes of the EUT.

During this testing any anomalies in the equipment under tests performance was recorded.



### **Specification Limits**

Required Test Levels					
Application	Level (A, m)	Duration	Performance Criteria		
Continuous Field	Continuous Field 30(for systems ≤32A) dependent on EUT operating cycle				
Supplementary information:					
Note 1. EUT power	Note 1. EUT powered at one of the Nominal input voltages and frequencies				

### **Test Results**

Performance assessment of the EUT made during this test: Pass

Detailed results are shown below.

Tabulated Results for Power Frequency Magnetic Immunity

	Tabulated Results for Power Frequency Magnetic Immunity				
Orientation	Operating Frequency	Test Frequency	Test Level	Duration	Result
X axis	50 Hz	50 Hz	30A, m	3 min	Α
Y axis	50 Hz	50 Hz	30A, m	3 min	Α
Z axis	50 Hz	50 Hz	30A, m	3 min	Α
X axis	60 Hz	60 Hz	30A, m	3 min	Α
Y axis	50 Hz	50 Hz	30A, m	3 min	Α
Z axis	60 Hz	60 Hz	30A, m	3 min	Α

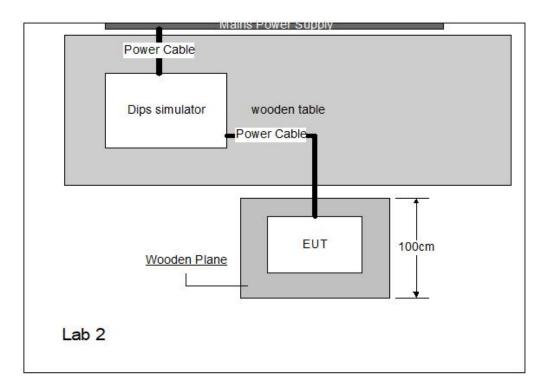
Remark: No observable change.

# Voltage dips, short interruptions and voltage variations immunity tests Test Method

The equipment under test including associated cabling was configured, on a 0.8 m non-conductive table for table-top equipment and on a 0.1 m insulated support for floor standing equipment above a ground reference plane all within a test laboratory.

Using a programmable power supply the equipment under test was subjected to the detailed supply voltage dips and interruptions. The required supply phase synchronization and test repetition rate, detailed, was controlled by the programmable power supply.

During this testing any anomalies in the equipment under tests performance was recorded.



### **Specification Limits**

Voltage Dips and short interruptions					
Voltage	Test level	Dura	Duration		
Dips in % UT	in % UT	50Hz	60Hz	- Criteria	
100	0	1 cycle	1 cycle	В	
60	40	10 cycles	12 cycles	В	
30	70	25 cycles	30 cycles	В	
100	0	250 cycles	300 cycles	С	
UT is the rated voltage of the Equipment Under Test					

### **Test Results**

Performance assessment of the EUT made during this test: Pass

Detailed results are shown below.

Tabulated Results for Voltage Dip and Short Interruption					
Line under test	Vnom	Operating Frequency	Test Level	Duration	Result
Power line	230 V~	50 Hz	0% of Vnom	1 cycle	А
Power line	230 V~	50 Hz	40% of Vnom	10 cycles	А
Power line	230 V~	50 Hz	70% of Vnom	25 cycles	А
Power line	230 V~	50 Hz	0% of Vnom	250 cycles	В

Remark: During 25, 30 cycles interruption test, the EUT stopped working. After the test, it can automatically return to normal status.

# **Test Equipment Information**

### **General Test Equipment Used**

### **Conducted Emission Test**

DESCRIPTION	MANUFACTURER	MODEL NO.	SERIAL NO.
Receiver (9K-3GHz)	Rohde & Schwarz	ESCI	100727
LISN	Rohde & Schwarz	ENV216	3506.6550.05
LISN	SCHWARZBECK	NSLK8163	05018
LISN	SCHWARZBECK	NNLK-8140	00136
LISN	SCHWARZBECK	NNLK-8140	00137
LISN	SCHWARZBECK	NNLK-8140	00138
LISN	SCHWARZBECK	NNLK-8140	00139
ISN	Rohde & Schwarz	ENY81	100389
ISN	Rohde & Schwarz	ENY81-CA6	101887
	Compliance		
RF Switch Box	Direction	RSU-M314-N	08042801
	Systems Inc.		

### Radiated Emission Test (SAC-3 area)

DESCRIPTION	MANUFACTURER	MODEL NO.	SERIAL NO.
EMI Test Receiver	Rohde & Schwarz	ESR 26	101702
Trilog Super Broadband Test Antenna	Schwarzbeck	VULB 9162	00341
Horn Antenna	Schwarzbeck	BBHA 9120D	02152
Loop Antenna	Schwarzbeck	FMZB 1519	1519-013
Pre-amplifier	Rohde & Schwarz	SCU08F1	101016
Pre-amplifier	Rohde & Schwarz	SCU 18	100759
3m Semi-anechoic chamber	TDK	SAC-3	

### Harmonic Test, Flicker Test

DESCRIPTION	MANUFACTURER	MODEL NO.	SERIAL NO.
3-phase analyzer for Harmonics and Flicker	EMTEST	DPA 503N	P2003237205
Multifunctional threephase voltage source	EMTEST	NetWave 67.3-400	P2009239095
3-phase Flicker impedance	EMTEST	AIF 503N63.1	P2009239213

### Electrostatic Discharge Test(ESD area)

DESCRIPTION	MANUFACTURER	MODEL NO.	SERIAL NO.
ESD Generator	EMTEST	ESD NX30	23124

### Radiated Immunity Test (SAC-3 area)

oot (one o area)			
DESCRIPTION	MANUFACTURER	MODEL NO.	SERIAL NO.
Signal Generator	Rohde & Schwarz	SMB100B	101903
Power Amplifier	Rohde & Schwarz	BBA150-BC 500	104061
Power Amplifier	Rohde & Schwarz	BBA150-D1 10E100	104048
Microwave Log-Periodic Antenna	Schwarzbeck	STLP9129 SET	3074
Average Power Sensor	Rohde & Schwarz	NRP6AN	101424
Average Power Sensor	Rohde & Schwarz	NRP6AN	101425

	3m FAC Chamber	TDK	CAC-3	
<b>Electrical Fast Trans</b>	sients Test(EMS area)			
	DESCRIPTION	MANUFACTURER	MODEL NO.	SERIAL NO.
	Compact Simulator	EMTEST	UCS 500N7.7	P1949235471
	3-phase coupling, decoupling network	EMTEST	CNI 503B9.4	P1740204286
	Capacitive Coupling Clamp	EMTEST	CCI	P2009239178
Surges Test(EMS ar	ea)			
	DESCRIPTION	MANUFACTURER	MODEL NO.	SERIAL NO.
	Compact Simulator	EMTEST	UCS 500N7.7	P1949235471
	3-phase coupling, decoupling network	EMTEST	CNI 503B9.4	P1740204286
	Telecom Surge Module	EMTEST	Tsurge 7	P1908227146
	Coupling, decoupling network for signal, datalinescoupling, decoupling network	EMTEST	CNV 504 N1	P1949235473
	coupling, decoupling network for unshielded symmetrical lines	EMTEST	CNV 508T5	P2004237741
	Railway coupler	EMTEST	PCN 7-R s-1	P2012240055
Conducted Immunit				
	DESCRIPTION	MANUFACTURER	MODEL NO.	SERIAL NO.
	Compact immunity	MANUFACTURER TESEQ	NSG	<b>SERIAL NO.</b> 56172
	Compact immunity test systemr			
	Compact immunity	TESEQ	NSG 4070C-110	56172
	Compact immunity test systemr 6dB Attenuator Coupling, Decoupling	TESEQ TESEQ	NSG 4070C-110 ATN 6150	56172 20011501
	Compact immunity test systemr 6dB Attenuator Coupling, Decoupling Network Coupling, Decoupling Network Current injection probe	TESEQ TESEQ EM TEST EMTEST EMTEST	NSG 4070C-110 ATN 6150 CDN M016S CDN M5-100-750 VS CIP 9136A	56172 20011501 56466
	Compact immunity test systemr 6dB Attenuator Coupling, Decoupling Network Coupling, Decoupling Network Courpling Network Current injection	TESEQ TESEQ EM TEST EMTEST	NSG 4070C-110 ATN 6150 CDN M016S CDN M5-100-750 VS	56172 20011501 56466 54984
Variation of power f	Compact immunity test systemr 6dB Attenuator Coupling, Decoupling Network Coupling, Decoupling Network Current injection probe	TESEQ TESEQ EM TEST EMTEST EMTEST TESE Q	NSG 4070C-110 ATN 6150 CDN M016S CDN M5-100-750 VS CIP 9136A	56172 20011501 56466 54984 56220
Variation of power f	Compact immunity test systemr 6dB Attenuator Coupling, Decoupling Network Coupling, Decoupling Network Current injection probe EM Clamp	TESEQ TESEQ EM TEST EMTEST EMTEST TESE Q	NSG 4070C-110 ATN 6150 CDN M016S CDN M5-100-750 VS CIP 9136A	56172 20011501 56466 54984 56220
Variation of power f	Compact immunity test systemr 6dB Attenuator Coupling, Decoupling Network Coupling, Decoupling Network Current injection probe EM Clamp	TESEQ TESEQ EM TEST EMTEST EMTEST TESE Q TESE Q	NSG 4070C-110 ATN 6150 CDN M016S CDN M5-100-750 VS CIP 9136A KEMA 801A	56172 20011501 56466 54984 56220 56676
	Compact immunity test systemr 6dB Attenuator Coupling, Decoupling Network Coupling, Decoupling Network Current injection probe EM Clamp requency Test (EMS ar DESCRIPTION Multifunctional threephase voltage source 3-phase Flicker impedance	TESEQ TESEQ EM TEST EMTEST EMTEST TESE Q ea) MANUFACTURER EMTEST EMTEST	NSG 4070C-110 ATN 6150 CDN M016S CDN M5-100-750 VS CIP 9136A KEMA 801A MODEL NO.	56172 20011501 56466 54984 56220 56676
	Compact immunity test systemr 6dB Attenuator Coupling, Decoupling Network Coupling, Decoupling Network Current injection probe EM Clamp requency Test (EMS ar DESCRIPTION Multifunctional threephase voltage source 3-phase Flicker impedance agnetic field Test(EMS	TESEQ TESEQ EM TEST EMTEST TESE Q TEAD MANUFACTURER EMTEST EMTEST EMTEST	NSG 4070C-110 ATN 6150 CDN M016S CDN M5-100-750 VS CIP 9136A KEMA 801A MODEL NO. NetWave 67.3-400 AIF 503N63.1	56172 20011501 56466 54984 56220 56676 SERIAL NO. P2009239095 P2009239213
	Compact immunity test systemr 6dB Attenuator Coupling, Decoupling Network Coupling, Decoupling Network Current injection probe EM Clamp requency Test (EMS and DESCRIPTION Multifunctional threephase voltage source 3-phase Flicker impedance agnetic field Test(EMS	TESEQ TESEQ EM TEST EMTEST EMTEST TESE Q ea) MANUFACTURER EMTEST EMTEST	NSG 4070C-110 ATN 6150 CDN M016S CDN M5-100-750 VS CIP 9136A KEMA 801A MODEL NO. NetWave 67.3-400 AIF	56172 20011501 56466 54984 56220 56676 SERIAL NO.
	Compact immunity test systemr 6dB Attenuator Coupling, Decoupling Network Coupling, Decoupling Network Current injection probe EM Clamp requency Test (EMS ar DESCRIPTION Multifunctional threephase voltage source 3-phase Flicker impedance agnetic field Test(EMS	TESEQ TESEQ EM TEST EMTEST TESE Q TEAD MANUFACTURER EMTEST EMTEST EMTEST	NSG 4070C-110 ATN 6150 CDN M016S CDN M5-100-750 VS CIP 9136A KEMA 801A MODEL NO. NetWave 67.3-400 AIF 503N63.1	56172 20011501 56466 54984 56220 56676 SERIAL NO. P2009239095 P2009239213

Measurement Uncertainty
For a 95% confidence level, the measurement uncertainties for defined systems are:

System Measurement Uncertainty			
Test Items	Extended Uncertainty		
Uncertainty for Conducted Emission in shielding	±3.22dB		
room			
150kHz-30MHz (for test using AMN ENV216 or			
ENV4200 or NSLK8163)			
Uncertainty for Radiated Emission in 3m chamber	Horizontal: ±5.13dB; Vertical:		
30MHz-1000MHz	±5.20dB;		
Uncertainty for Radiated Emission in 3m chamber	Horizontal: ±5.02dB; Vertical:		
1000MHz-18000MHz	±5.02dB;		
Uncertainty for Harmonic test	3.16%		
Uncertainty for Flicker test	4.69%		
Uncertainty for RS test	49%, K=2		
Uncertainty for CS test	28%(CDN); 45%(EM Clamp) K=2		
Uncertainty for ESD test	The immunity measurement		
Uncertainty for EFT test	system uncertainty is within		
Uncertainty for Surges test	standard requirement and is		
Uncertainty for PMF test	based on a standard uncertainty		
Uncertainty for Voltage Dips, Voltage Variations	multiplied by a coverage factor		
and Short Interruptions Test	k=2, providing a level of		
·	confidence of approximately		
	95%.		

### Remark:

Measurement Uncertainty Decision Rule

Determination of conformity with the specification limits is based on the decision rule according to IEC Guide 115: 2007, clause 4.4.3 and 4.5.1.

# **Photo of Product**





